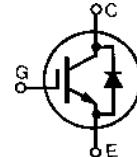


# HiPerFAST™ IGBT with Diode Combi Pack

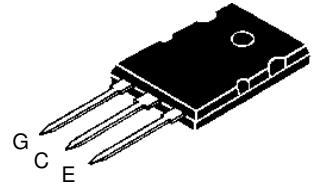
**IXGK 50N50BU1**  
**IXGK 50N60BU1**

<b>V<sub>CES</sub></b>	<b>I<sub>C25</sub></b>	<b>V<sub>CE(sat)</sub></b>	<b>t<sub>fi</sub></b>
500 V	75 A	2.3 V	100ns
600 V	75 A	2.5 V	120ns

Preliminary data



TO-264 AA



G = Gate, C = Collector,  
E = Emitter, TAB = Collector

<b>Symbol</b>	<b>Test Conditions</b>	<b>Maximum Ratings</b>		<b>50N50</b>	<b>50N60</b>
		<b>50N50</b>	<b>50N60</b>		
<b>V<sub>CES</sub></b>	T <sub>J</sub> = 25°C to 150°C	500	600	V	V
<b>V<sub>CGR</sub></b>	T <sub>J</sub> = 25°C to 150°C; R <sub>GE</sub> = 1 MΩ	500	600	V	V
<b>V<sub>GES</sub></b>	Continuous	±20	±20	V	V
<b>V<sub>GEM</sub></b>	Transient	±30	±30	V	V
<b>I<sub>C25</sub></b>	T <sub>C</sub> = 25°C	75	75	A	A
<b>I<sub>C90</sub></b>	T <sub>C</sub> = 90°C	50	50	A	A
<b>I<sub>CM</sub></b>	T <sub>C</sub> = 25°C, 1 ms	200	200	A	A
<b>SSOA (RBSOA)</b>	V <sub>GE</sub> = 15 V, T <sub>VJ</sub> = 125°C, R <sub>G</sub> = 10 Ω Clamped inductive load, L = 30 μH	I <sub>CM</sub> = 100 @ 0.8 V <sub>CES</sub>	A		
<b>P<sub>c</sub></b>	T <sub>C</sub> = 25°C	300	300	W	W
<b>T<sub>J</sub></b>		-55 ... +150		°C	
<b>T<sub>JM</sub></b>		150		°C	
<b>T<sub>stg</sub></b>		-55 ... +150		°C	
<b>M<sub>d</sub></b>	Mounting torque (M4)	0.9/6	Nm/lb.in.		
<b>Weight</b>		10	g		
Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s		300	°C		

## Features

- International standard package JEDEC TO-264 AA
- High frequency IGBT and anti-parallel FRED in one package
- 2nd generation HDMOS™ process
- Low V<sub>CE(sat)</sub>
  - for minimum on-state conduction losses
- MOS Gate turn-on
  - drive simplicity
- Fast Recovery Epitaxial Diode (FRED)
  - soft recovery with low I<sub>RM</sub>

## Applications

- AC motor speed control
- DC servo and robot drives
- DC choppers
- Uninterruptible power supplies (UPS)
- Switch-mode and resonant-mode power supplies

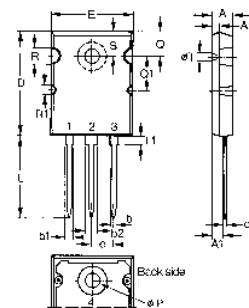
## Advantages

- Space savings (two devices in one package)
- Easy to mount with 1 screw (isolated mounting screw hole)
- Reduces assembly time and cost
- High power density

<b>Symbol</b>	<b>Test Conditions</b>	<b>Characteristic Values</b>		
		(T <sub>J</sub> = 25°C, unless otherwise specified)		
		<b>min.</b>	<b>typ.</b>	<b>max.</b>
<b>BV<sub>CES</sub></b>	I <sub>C</sub> = 500 μA, V <sub>GE</sub> = 0 V	50N50	500	V
		50N60	600	V
<b>V<sub>GE(th)</sub></b>	I <sub>C</sub> = 500 μA, V <sub>CE</sub> = V <sub>GE</sub>		2.5	V
<b>I<sub>CES</sub></b>	V <sub>CE</sub> = 0.8 • V <sub>CES</sub> V <sub>GE</sub> = 0 V	T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C		250 μA 15 mA
<b>I<sub>GES</sub></b>	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = ±20 V			±100 nA
<b>V<sub>CE(sat)</sub></b>	I <sub>C</sub> = I <sub>C90</sub> , V <sub>GE</sub> = 15 V	50N50BU1 50N60BU1		2.3 V 2.5 V

Symbol	Test Conditions	Characteristic Values		
		( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	min.	typ.
$g_{fs}$	$I_C = I_{C90}$ ; $V_{CE} = 10 \text{ V}$ , Pulse test, $t \leq 300 \mu\text{s}$ , duty cycle $\leq 2\%$ Remarks: Add capacitance from IXGH50N60B (DS95585B)	25	35	S
$Q_g$	$I_C = I_{C90}$ , $V_{GE} = 15 \text{ V}$ , $V_{CE} = 0.5 V_{CES}$	200	nC	
$Q_{ge}$		50	nC	
$Q_{gc}$		70	nC	
$t_{d(on)}$	<b>Inductive load, <math>T_J = 25^\circ\text{C}</math></b> $I_C = I_{C90}$ , $V_{GE} = 15 \text{ V}$ , $L = 100 \mu\text{H}$ , $V_{CE} = 0.8 V_{CES}$ , $R_G = R_{off} = 2.7 \Omega$ Remarks: Switching times may increase for $V_{CE}$ (Clamp) $> 0.8 \cdot V_{CES}$ , higher $T_J$ or increased $R_G$	50	ns	
$t_{ri}$		50	ns	
$t_{d(off)}$		110	ns	
$t_{fi}$		50N50 150	80 ns	
$E_{off}$		50N50 50N60	1.8 3.0	mJ mJ
$t_{d(on)}$	<b>Inductive load, <math>T_J = 125^\circ\text{C}</math></b> $I_C = I_{C90}$ , $V_{GE} = 15 \text{ V}$ , $L = 100 \mu\text{H}$ , $V_{CE} = 0.8 V_{CES}$ , $R_G = R_{off} = 2.7 \Omega$ Remarks: Switching times may increase for $V_{CE}$ (Clamp) $> 0.8 \cdot V_{CES}$ , higher $T_J$ or increased $R_G$	50	ns	
$t_{ri}$		60	ns	
$E_{on}$		3	mJ	
$t_{d(off)}$		200	ns	
$t_{fi}$		50N50 50N60	100 250	ns
$E_{off}$		50N50 50N60	2.6 4.2	mJ mJ
$R_{thJC}$			0.42	K/W
$R_{thCK}$		0.15		K/W

## TO-264 AA Outline



Dim.	Millimeter Min.	Millimeter Max.	Inches Min.	Inches Max.
A	4.82	5.13	.190	.202
A1	2.54	2.89	.100	.114
A2	2.00	2.10	.079	.083
b	1.12	1.42	.044	.056
b1	2.39	2.69	.094	.106
b2	2.90	3.09	.114	.122
c	0.53	0.83	.021	.033
D	25.91	26.16	1.020	1.030
E	19.81	19.96	.780	.786
e	5.46	BSC	.215	BSC
J	0.00	0.25	.000	.010
K	0.00	0.25	.000	.010
L	20.32	20.83	.800	.820
L1	2.29	2.59	.090	.102
P	3.17	3.66	.125	.144
Q	6.07	6.27	.239	.247
Q1	8.38	8.69	.330	.342
R	3.81	4.32	.150	.170
R1	1.78	2.29	.070	.090
S	6.04	6.30	.238	.248
T	1.57	1.83	.062	.072

## Reverse Diode (FRED)

Symbol	Test Conditions	Characteristic Values		
		( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	min.	typ.
$V_F$	$I_F = I_{C90}$ , $V_{GE} = 0 \text{ V}$ , Pulse test, $t \leq 300 \mu\text{s}$ , duty cycle $d \leq 2\%$		1.7	V
$I_{RM}$	$I_F = I_{C90}$ , $V_{GE} = 0 \text{ V}$ , $-di_F/dt = 480 \text{ A}/\mu\text{s}$ $V_R = 360 \text{ V}$ $I_F = 1 \text{ A}$ ; $-di/dt = 200 \text{ A}/\mu\text{s}$ ; $V_R = 30 \text{ V}$	19	33	A
		175	ns	
		35	50	ns
$R_{thJC}$			0.75	K/W

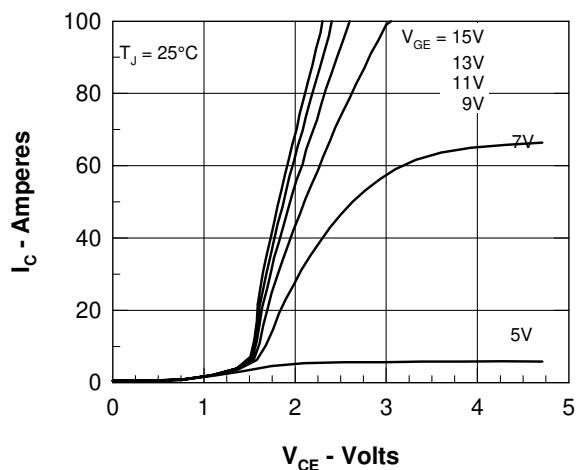


Figure 1. Saturation Voltage Characteristics

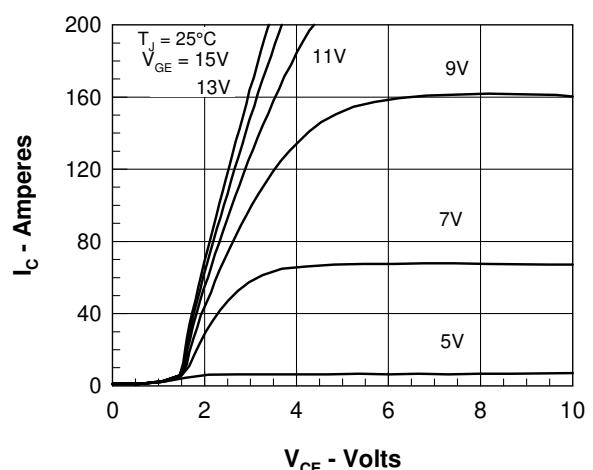


Figure 2. Extended Output Characteristics

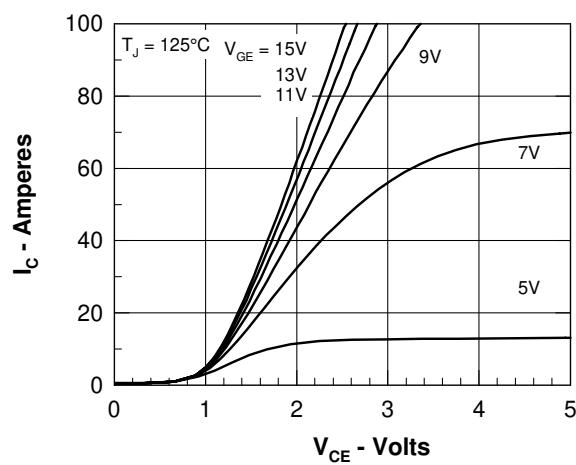


Figure 3. Saturation Voltage Characteristics

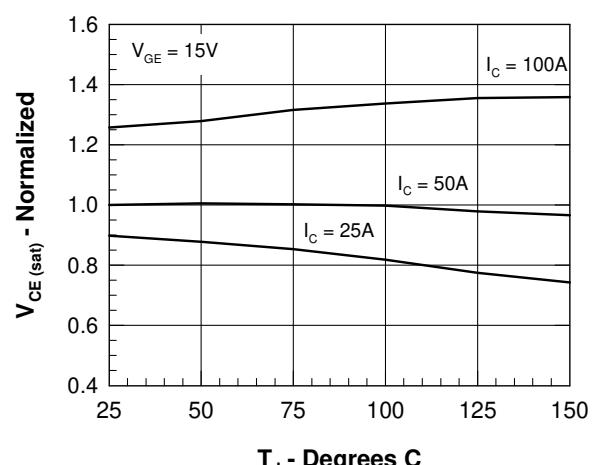
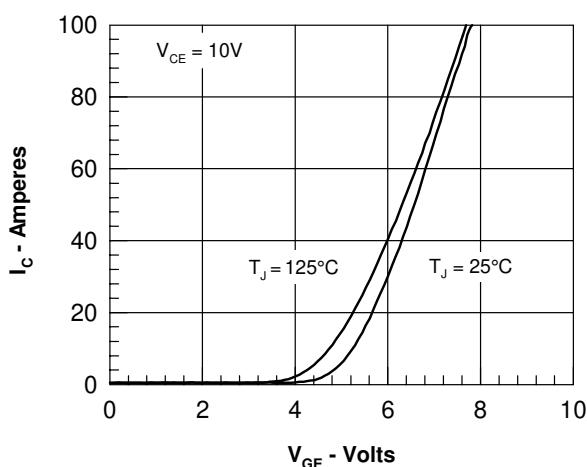
Figure 4. Temperature Dependence of  $V_{CE(sat)}$ 

Figure 5. Admittance Curves

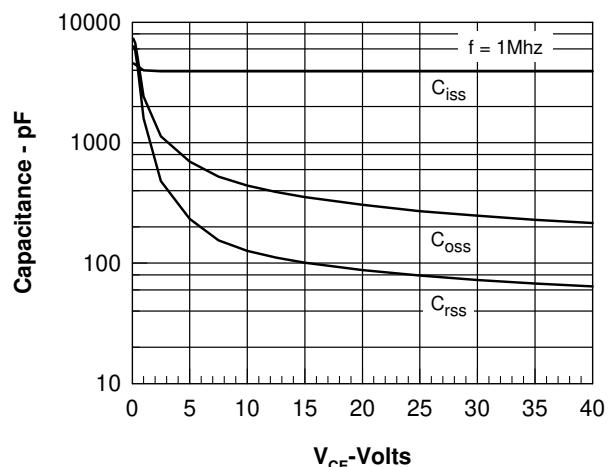


Figure 6. Capacitance Curves

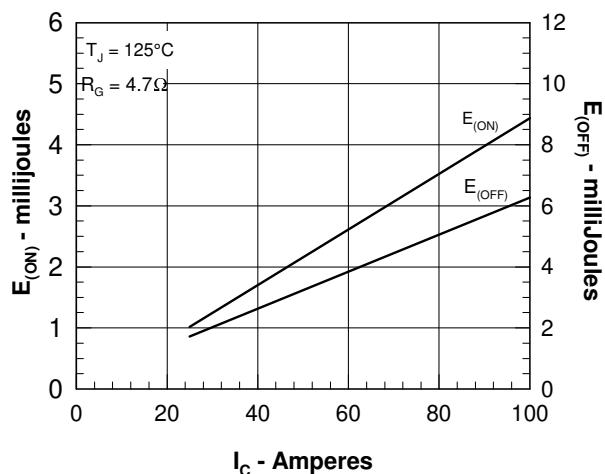
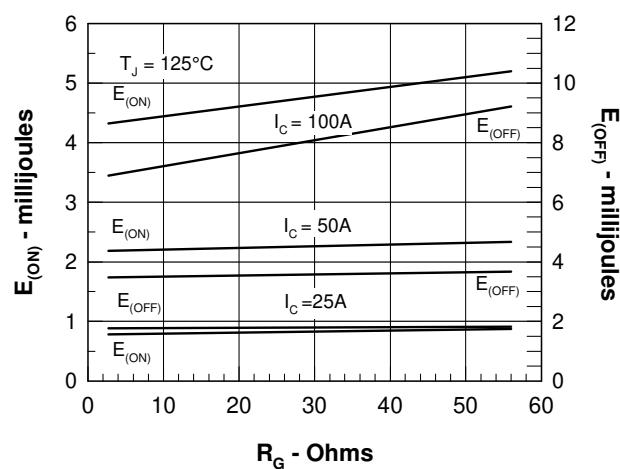
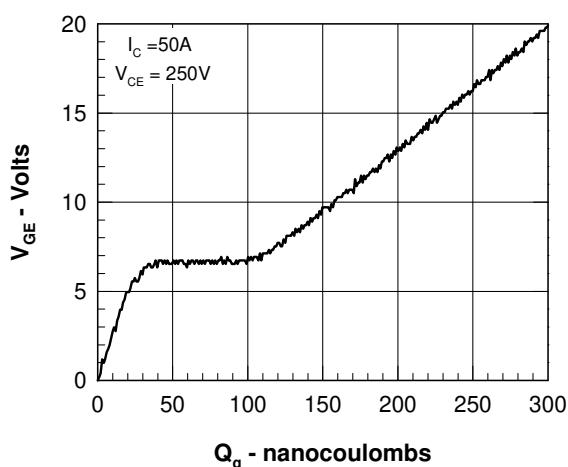
Figure 7. Dependence of  $E_{(ON)}$  and  $E_{(OFF)}$  on  $I_c$ .Figure 8. Dependence of  $E_{(ON)}$  and  $E_{(OFF)}$  on  $R_G$ .

Figure 9. Gate Charge

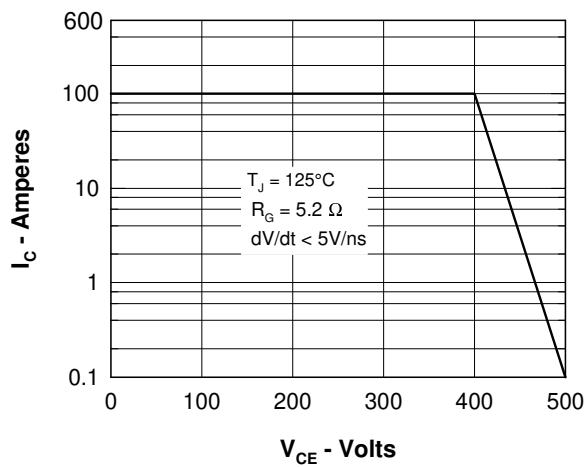


Figure 10. Turn-off Safe Operating Area

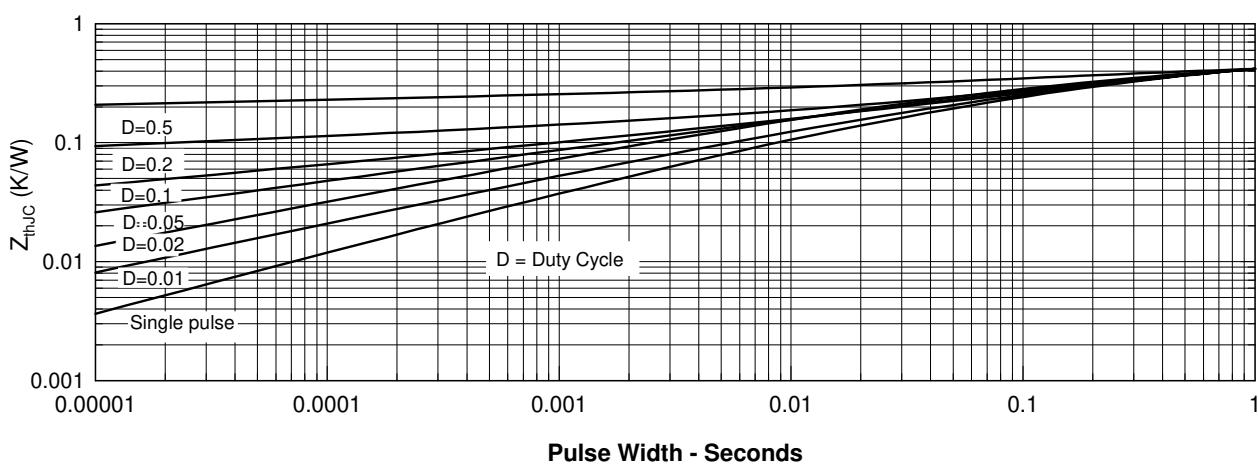


Figure 11. IGBT Transient Thermal Resistance

Fig. 12. Maximum Forward Voltage Drop

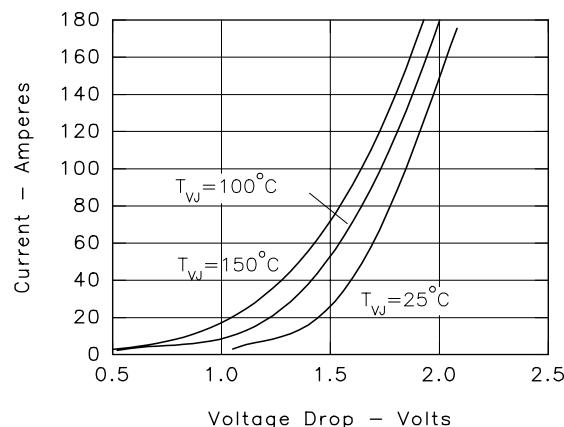
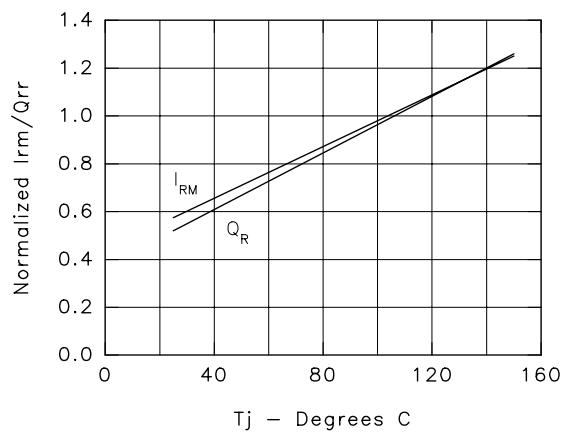
Fig. 14. Junction Temperature Dependence of  $I_{RM}$  and  $Q_R$ .

Figure 16. Peak Reverse Recovery Current.

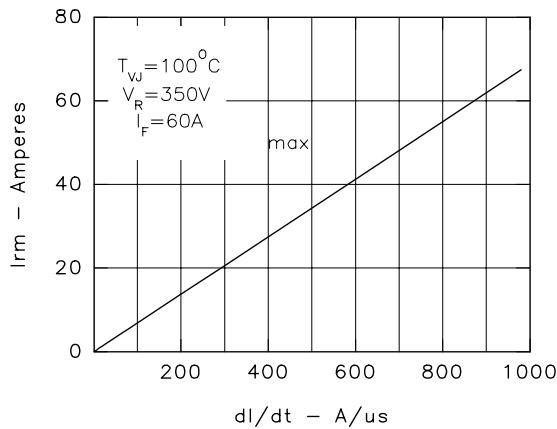
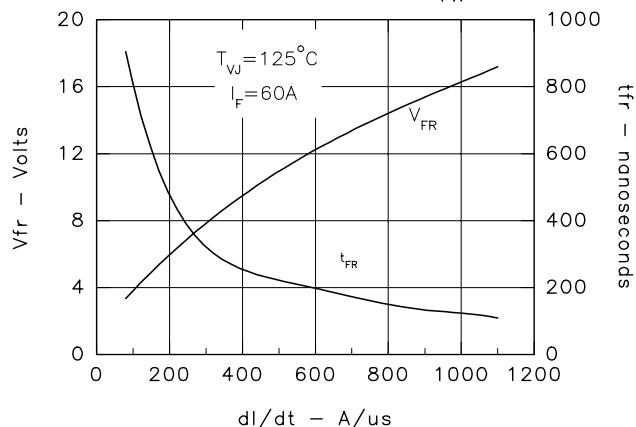
Fig. 13. Peak Forward Voltage  $V_{FR}$  and Forward Recovery Time  $t_{FR}$ .

Fig. 15. Maximum Reverse Recovery Charge

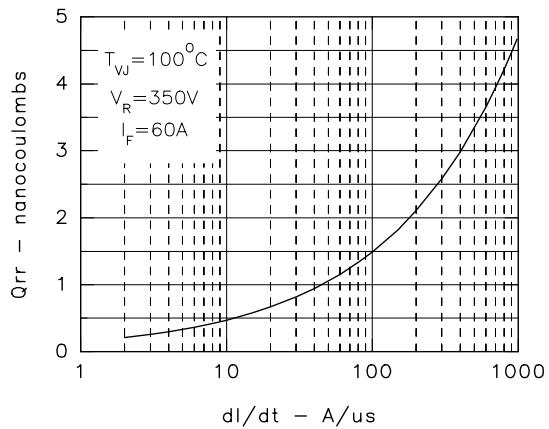
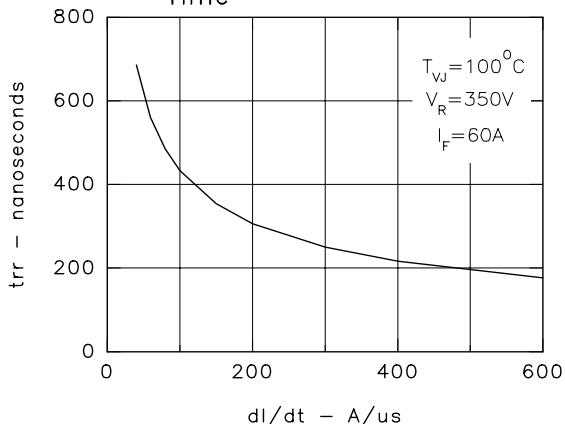


Fig. 17. Maximum Reverse Recovery Time



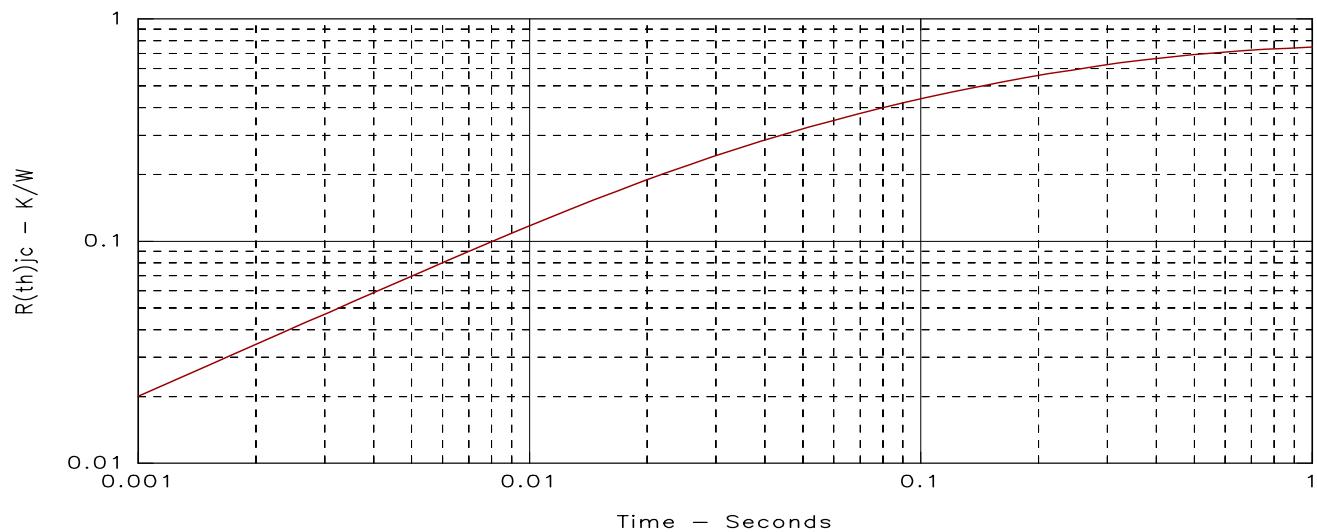


Fig. 18. Diode transient thermal resistance junction-to-case.